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1	IS&R	L1	926	(382/100,299).CCLS	USPA T	2003/10/14 14:07			0
2	BRS	L2	762	1 and obtain\$6	USPA T	2003/10/14 14:22			0
3	BRS	L3	6	2 and ( reduc\$4 near4 second adj image)	USPA T	2003/10/14 14:14			0
4	BRS	L5	3	4 and ratio	USPA T	2003/10/14 14:09			0
5	BRS	L6	3	5 and siz\$4	USPA T	2003/10/14 14:09			0
6	BRS	L7	3	6 and aspect\$4	USPA T	2003/10/14 14:09			0
7	BRS	L4	6	3 and process\$4	USPA T	2003/10/14 14:22			0
8	BRS	L8	716	(aspect\$4 near3 siz\$4 near4 ratio) and reduc\$4 and image	USPA T	2003/10/14 14:20			0
9	BRS	L9	2	8 and ( reduc\$4 near4 second adj image)	USPA T	2003/10/14 14:20			0
10	BRS	L10	1437	(aspect\$4 near3 siz\$4 near4 ratio) and reduc\$4	USPA T	2003/10/14 14:20			0
11	BRS	L11	2	10 and ( reduc\$4 near4 second adj image)	USPA T	2003/10/14 14:34			0
12	BRS	L12	2	11 and obtain\$6	USPA T	2003/10/14 14:22			0
13	BRS	L13	2	12 and process\$4	USPA T	2003/10/14 14:22			0
14	BRS	L14	2	13 and ( first adj image)	USPA T	2003/10/14 14:34			0
15	BRS	L15	2	14 and ( second adj image)	USPA T	2003/10/14 14:33			0
16	BRS	L18	0	17 and range	USPA T	2003/10/14 14:24			0

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17	BRS	L19	0	17 and lateral	USPA T	2003/10 /14 14:24			0
18	BRS	L17	2	15 and ( third adj image)	USPA T	2003/10 /14 14:27			0
19	BRS	L20	4586 7	image adj process\$5	USPA T	2003/10 /14 14:28			0
20	BRS	L21	1240	20 and (lateral adj direction)	USPA T	2003/10 /14 14:28			0
21	BRS	L22	5768	20 and (vertical adj direction)	USPA T	2003/10 /14 14:28			0
22	BRS	L23	579	21 and (vertical adj direction)	USPA T	2003/10 /14 14:28			0
23	BRS	L24	0	23 and ((first adj image ) near3 (range))	USPA T	2003/10 /14 14:29			0
24	BRS	L25	115	23 and ((image ) near3 (range))	USPA T	2003/10 /14 14:30			0
25	BRS	L26	108	25 and add\$6	USPA T	2003/10 /14 14:30			0
26	BRS	L27	93	26 and information	USPA T	2003/10 /14 14:30			0
27	BRS	L28	0	27 and longitudianl	USPA T	2003/10 /14 14:31			0
28	BRS	L29	42	27 and arbitrary	USPA T	2003/10 /14 14:32			0
29	BRS	L30	0	29 and ( reduc\$4 near4 second adj image)	USPA T	2003/10 /14 14:33			0
30	BRS	L31	5	29 and ( second adj image)	USPA T	2003/10 /14 14:33			0
31	BRS	L32	4	31 and ( first adj image)	USPA T	2003/10 /14 14:34			0
32	BRS	L33	4	32 and ( reduc\$4)	USPA T	2003/10 /14 14:36			0
33	BRS	L34	3	33 and target\$4	USPA T	2003/10 /14 14:36			0

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Solid-State Circuits, IEEE Journal of , Volume: 24 Issue: 3  
, Jun 1989

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[\[Abstract\]](#) [\[PDF Full-Text \(672 KB\)\]](#) **IEEE JNL****2 A 2-million-pixel CCD image sensor overlaid with an amorphous silicon photoconversion layer***Manabe, S.; Mastunaga, Y.; Furukawa, A.; Yano, K.;*  
*Endo, Y.; Miyagawa, R.; Iida, Y.; Egawa, Y.; Shibata, H.;*  
*Nozaki, H.; Sakuma, N.; Harada, N.;*

Electron Devices, IEEE Transactions on , Volume: 38

Issue: 8 , Aug. 1991

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[\[Abstract\]](#) [\[PDF Full-Text \(1064 KB\)\]](#) **IEEE JNL****3 6-MHz 2-N/m piezoresistive atomic-force microscope cantilevers with INCISIVE tips***Ried, R.P.; Mamin, H.J.; Terris, B.D.; Long-Sheng Fan;*  
*Rugar, D.;*

Microelectromechanical Systems, Journal of , Volume: 6

Issue: 4 , Dec. 1997

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